Empirical Process

(Chapter 4) Chaining and uniform entropy

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Theorem 4.1 (Dudley's entropy bound for finite T)

Suppose that $\{X_t : t \in T\}$ is a mean zero stochastic process such that for every $s, t \in T$ and $u \ge 0$,

$$\mathbb{P}\left\{|X_t - X_s| \ge u\right\} \le 2\exp\left(-\frac{u^2}{2d^2(s,t)}\right) \tag{1}$$

Also, assume that (T, d) is a finite metric space. Then, we have

$$\mathbb{E} \sup_{t \in T} X_t \le C \int_0^\infty \sqrt{\log N(\epsilon, T, d)} d\epsilon \tag{2}$$

where C > 0 is a constant.

Proposition 4.2

Let T be a finite set and let $X_t, t \in T$ be a stochastic process. Suppose that for every $t \in T$ and $u \ge 0$, the inequality

$$\mathbb{P}(|X_t| \ge u) \le 2 \exp\left(-\frac{u^2}{2\sigma^2}\right) \tag{3}$$

holds. Then, for a universal positive constant C, we have

$$\mathbb{E}\max_{t\in T}|X_t| \le C\sigma\sqrt{\log(2|T|)} \tag{4}$$

Proof of Proposition 4.2

First,

$$\mathbb{E} \max_{t \in T} |X_t| = \int_0^\infty \mathbb{P} \left(\max_{t \in T} |X_t| \ge u \right) du$$

we can write

$$\mathbb{P}\left(\max_{t\in\mathcal{T}}|X_t|\geq u\right) = \mathbb{P}\left(\cup_{t\in\mathcal{T}}\left\{|X_t|\geq u\right\}\right) \leq \sum_{t\in\mathcal{T}}\mathbb{P}\left(|X_t|\geq u\right) \leq 2|\mathcal{T}|\exp\left(-\frac{u^2}{2\sigma^2}\right)$$

This bound is good for $u \ge u_0$ for some u_0 to be specified later. This gives

$$\begin{split} \mathbb{E} \max_{t \in T} |X_t| &= \int_0^{u_0} \mathbb{P}\left(\max_{t \in T} |X_t| \geq u\right) du + \int_{u_0}^{\infty} \mathbb{P}\left(\max_{t \in T} |X_t| \geq u\right) du \\ &\leq u_0 + \int_{u_0}^{\infty} 2|T| \exp\left(-\frac{u^2}{2\sigma^2}\right) du \\ &\leq u_0 + \int_{u_0}^{\infty} 2|T| \frac{u}{u_0} \exp\left(-\frac{u^2}{2\sigma^2}\right) du = u_0 + \frac{2|T|}{u_0} \sigma^2 \exp\left(-\frac{u_0^2}{2\sigma^2}\right) \end{split}$$

Proof of Proposition 4.2 (continued)

Here, we can set

$$u_0 = \sqrt{2}\sigma\sqrt{\log(2|T|)}$$

that is,

$$\exp\left(\frac{u_0^2}{2\sigma^2}\right) = 2|T|$$

This gives

$$\mathbb{E} \max_{t \in T} |X_t| \leq \sqrt{2}\sigma \sqrt{\log(2|T|)} + \frac{\sigma^2}{\sqrt{2\sigma^2 \log(2|T|)}} \leq C\sigma \sqrt{\log(2|T|)}$$

which proves the result.

Theorem 4.3

Suppose (T,d) is a finite metric space and $\{X_t, t \in T\}$ is a stochastic process such that (1) hold. Then, for a universal positive constant C, the following inequality holds for every $t_0 \in T$:

$$\mathbb{E} \max_{t \in T} |X_t - X_{t_0}| \le C \int_0^\infty \sqrt{\log D(\epsilon, T, d)} d\epsilon \lesssim \int_0^\infty \sqrt{\log N(\epsilon, T, d)} d\epsilon \qquad (5)$$

Here $D(\epsilon, T, d)$ denotes the ϵ -packing number of the space (T, d).

Remark 4.1

Let \tilde{D} denote the diameter of the metric space T. Then $D(\epsilon, T, d)$ clearly equals 1 for $\epsilon \geq \tilde{D}$. Therefore,

$$\int_0^\infty \sqrt{\log D(\epsilon, T, d)} d\epsilon = \int_0^{\tilde{D}} \sqrt{\log D(\epsilon, T, d)} d\epsilon$$

Moreover,

$$\begin{split} \int_{0}^{\tilde{D}} \sqrt{\log D(\epsilon, T, d)} d\epsilon &= \int_{0}^{\tilde{D}/2} \sqrt{\log D(\epsilon, T, d)} d\epsilon + \int_{\tilde{D}/2}^{\tilde{D}} \sqrt{\log D(\epsilon, T, d)} d\epsilon \\ &= \int_{0}^{\tilde{D}/2} \sqrt{\log D(\epsilon, T, d)} d\epsilon + \int_{0}^{\tilde{D}/2} \sqrt{\log D(\epsilon + (\tilde{D}/2), T, d)} d\epsilon \\ &\leq 2 \int_{0}^{\tilde{D}/2} \sqrt{\log D(\epsilon, T, d)} d\epsilon \end{split}$$

because $D(\epsilon + (\tilde{D}/2), T, d) \leq D(\epsilon, T, d)$ for every ϵ .

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Remark 4.1 (continued)

We can thus state Dudley's bound as

$$\mathbb{E} \max_{t \in T} |X_t - X_{t_0}| \le C \int_0^{\tilde{D}/2} \sqrt{\log D(\epsilon, T, d)} d\epsilon$$

Similarly, again by splitting the above integral in two parts, we can also state Dudley's bound as

$$\mathbb{E} \max_{t \in T} |X_t - X_{t_0}| \le C \int_0^{\tilde{D}/4} \sqrt{\log D(\epsilon, T, d)} d\epsilon$$

Proof of Theorem 4.3

For $n \geq 1$, let T_n be a maximal $\tilde{D}2^{-n}$ -separated subset of T and T_n be a maximal cardinality subject to the separation restriction. The cardinality of T_n is given by the packing number $D\left(\tilde{D}2^{-n},T,d\right)$. Because of the maximality,

$$\max_{t \in T} \min_{s \in T_n} d(s, t) \le \tilde{D} 2^{-n} \tag{6}$$

Because T is finite and d(s,t) > 0 for all $s \neq t$, the set T_n will equal T when n is large. Let

$$N := \min \left\{ n \ge 1 : T_n = T \right\}$$

For each $n \ge 1$, let $\pi_n : T \to T_n$ denote the function which maps each point $t \in T$ to the point in T_n that is closest to T. In other words, $\pi_n(t)$ is chosen so that

$$d(t,\pi_n(t)) = \min_{s \in T_n} d(t,s)$$

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Proof of Theorem 4.3 (continued)

From (6), we have

$$d(t, \pi_n(t)) \le \tilde{D}2^{-n}$$
 for all $t \in T$ and $n \ge 1$ (7)

Note that $\pi_0(t) = t_0$ and $\pi_N(t) = t$ for all $t \in T$. Now

$$X_t - X_{t_0} = \sum_{n=1}^{N} (X_{\pi_n(t)} - X_{\pi_{n-1}(t)})$$
 for every $t \in T$ (8)

By (8), we obtain

$$\max_{t \in T} |X_t - X_{t_0}| \le \max_{t \in T} \sum_{n=1}^{N} |X_{\pi_n(t)} - X_{\pi_{n-1}(t)}| \le \sum_{n=1}^{N} \max_{t \in T} |X_{\pi_n(t)} - X_{\pi_{n-1}(t)}|$$

so that

$$\mathbb{E} \max_{t \in T} |X_t - X_{t_0}| \le \sum_{t \in T}^{N} \mathbb{E} \max_{t \in T} |X_{\pi_n(t)} - X_{\pi_{n-1}(t)}|$$
 (9)

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Proof of Theorem 4.3 (continued)

For the elementary bound given by Proposition 4.2, note first that by (1), we have

$$\mathbb{P}\left\{\left|X_{\pi_{n}(t)}-X_{\pi_{n-1}(t)}\right|\geq u\right\}\leq 2\exp\left(\frac{-u^{2}}{2d^{2}\left(\pi_{n}(t),\pi_{n-1}(t)\right)}\right)$$

Now

$$d\left(\pi_{n}(t), \pi_{n-1}(t)\right) \leq d\left(\pi_{n}(t), t\right) + d\left(\pi_{n-1}(t), t\right) \leq \tilde{D}2^{-n} + \tilde{D}2^{-(n-1)} = 3\tilde{D}2^{-n}$$

Thus Proposition 4.2 can be applied with $\sigma:=3\tilde{D}2^{-n}$ so that we obtain

$$\begin{split} \mathbb{E} \max_{t \in T} \left| X_{\pi_{n}(t)} - X_{\pi_{n-1}(t)} \right| &\leq C \frac{3\tilde{D}}{2^{n}} \sqrt{\log\left(2\left|T_{n}\right|\left|T_{n-1}\right|\right)} \\ &\leq C \tilde{D} 2^{-n} \sqrt{\log\left(2\left|T_{n}\right|^{2}\right)} \\ &\leq C \tilde{D} 2^{-n} \sqrt{\log\left(2D\left(\tilde{D} 2^{-n}, T, d\right)\right)} \end{split}$$

Proof of Theorem 4.3 (continued)

Plugging the above bound into (9), we deduce

$$\mathbb{E} \max_{t \in T} |X_t - X_{t_0}| \le C \sum_{n=1}^{N} \frac{\tilde{D}}{2^n} \sqrt{\log \left(2D\left(\tilde{D}2^{-n}, T, d\right)\right)}$$

$$\le 2C \sum_{n=1}^{N} \int_{\tilde{D}/2^{n+1}}^{\tilde{D}/2^n} \sqrt{\log(2D(\epsilon, T, d))} d\epsilon$$

$$\le 2C \int_{0}^{\tilde{D}/4} \sqrt{\log(2D(\epsilon, T, d))} d\epsilon$$

Note that for $\epsilon \leq \tilde{D}/4$, the packing number $D(\epsilon, T, d) \geq 2$ so that

$$\log(2D(\epsilon, T, d)) = \log 2 + \log D(\epsilon, T, d) \le 2 \log D(\epsilon, T, d)$$

We have thus proved that

$$\mathbb{E} \max_{t \in T} |X_t - X_{t_0}| \le 2\sqrt{2}C \int_0^{\tilde{D}/4} \sqrt{\log D(\epsilon, T, d)} d\epsilon$$

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Definition 4.4 (Separable stochastic process)

Let (T,d) be a metric space. The stochastic process $\{X_t,t\in T\}$ indexed by T is said to be separable if there exists a null set N and a countable subset \tilde{T} of T such that for all $\omega\notin N$ and $t\in N$, there exists a sequence $\{t_n\}$ in \tilde{T} with $\lim_{n\to\infty} d(t_n,t)=0$ and $\lim_{n\to\infty} X_{t_n}(\omega)=X_t(\omega)$.

If $\{X_t, t \in T\}$ is a separable stochastic process, then

$$\sup_{t \in T} |X_t - X_{t_0}| = \sup_{t \in \tilde{T}} |X_t - X_{t_0}| \quad \text{almost surely}$$
 (10)

for every $t_0 \in \mathcal{T}$. Here $\tilde{\mathcal{T}}$ is a countable subset of \mathcal{T} which appears in the definition of separability of $X_t, t \in \mathcal{T}$.

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Theorem 4.5

Let (T, d) be a separable metric space and let $(X_t, t \in T)$ be a separable stochastic process. Suppose that for every $s, t \in T$ and $u \ge 0$, we have

$$\mathbb{P}\left\{|X_s - X_t| \ge u\right\} \le 2\exp\left(-\frac{u^2}{2d^2(s,t)}\right)$$

Then for every $t_0 \in T$, we have

$$\mathbb{E} \sup_{t \in T} |X_t - X_{t_0}| \le C \int_0^{\tilde{D}/4} \sqrt{\log D(\epsilon, T, d)} d\epsilon \tag{11}$$

where \tilde{D} is the diameter of the metric space (T, d).

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Proof of Theorem 4.5

Let \tilde{T} be a countable subset of T. We may assume that \tilde{T} contains t_0 (otherwise simply add t_0 to \tilde{T}). For each $k \geq 1$, let \tilde{T}_k be the finite set obtained by taking the first k elements of \tilde{T} .

Applying Theorem 4.3 to $\{X_t, t \in \tilde{T}_k\}$, we obtain

$$\mathbb{E} \max_{t \in \tilde{T}_k} |X_t - X_{t_0}| \leq C \int_0^{\operatorname{diam}(\tilde{T}_k)/4} \sqrt{\log D(\epsilon, \tilde{T}_k, d)} d\epsilon \leq C \int_0^{\tilde{D}/4} \sqrt{\log D(\epsilon, T, d)} d\epsilon$$

Letting $k \to \infty$, we obtain

$$\mathbb{E} \sup_{t \in \tilde{T}} |X_t - X_{t_0}| \le C \int_0^{\tilde{D}/4} \sqrt{\log D(\epsilon, T, d)} d\epsilon$$

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Definition 4.6 (Uniform entropy bound)

A class $\mathcal F$ of measurable functions with measurable envelope F satisfies the uniform entropy bound if and only if $J(1,\mathcal F,F)<\infty$ where

$$J(\delta, \mathcal{F}, F) := \int_0^\delta \sup_{Q} \sqrt{\log N(\epsilon ||F||_{Q,2}, \mathcal{F} \cup \{0\}, L_2(Q))} d\epsilon, \quad \delta > 0$$
 (12)

Fitness of the integral will be referred to as the uniform entropy condition.

Theorem 4.7

If ${\mathcal F}$ is a class of measuable functions with measurable envelop function ${\mathcal F}$, then

$$\mathbb{E}\left[\|\mathbb{G}_n\|_{\mathcal{F}}\right] \lesssim \mathbb{E}\left[J\left(\theta_n, \mathcal{F}, F\right) \|F\|_n\right] \lesssim J(1, \mathcal{F}, F) \|F\|_{P, 2} \tag{13}$$

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where $\theta_n := \sup_{f \in \mathcal{F}} \|f\|_n / \|F\|_n$ and $\mathbb{G}_n(f) = \sqrt{n} (\mathbb{P}_n - P) (f)$.

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Proof of Theorem 4.7

Recall that

Lemma 3.12 (Hoeffding's inequality for Rademacher variables)

Let $a=(a_1,\ldots,a_n)\in\mathbb{R}^n$ be a vector of constants and $\varepsilon_1,\ldots,\varepsilon_n$ be rademacher random variables. Then

$$\mathbb{P}\left(\left|\sum_{i=1}^n a_i \varepsilon_i\right| \ge x\right) \le 2e^{-x^2/\left(2\|a\|^2\right)}$$

where ||a|| denotes the Euclidean norm of a.

Theorem 3.17 (Symmetrisation)

Fro any class of measurable function \mathcal{F} ,

$$\mathbb{E} \|\mathbb{P}_n - P\|_{\mathcal{F}} \leq 2\mathbb{E} \left\| \frac{1}{n} \sum_{i=1}^n \varepsilon_i f(X_i) \right\|_{\mathcal{F}}$$

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Proof of Theorem 4.7 (continued)

It suffices to bound $\mathbb{E} \|\mathbb{G}_n^o\|_{\mathcal{F}}$; recall that $\mathbb{G}_n^o(f) = \frac{1}{\sqrt{n}} \sum_{i=1}^n \varepsilon_i f(X_i)$ where ε_i 's are i.i.d. Rademacher (by Theorem 3.17). Given X_1, \ldots, X_n , the process \mathbb{G}_n^o is sub-Gaussian for the $L_2(\mathbb{P}_n)$ -seminorm $\|\cdot\|_n$ (by Lemma 3.12), i.e.,

$$\mathbb{P}\left(\left|\sum_{i=1}^n \varepsilon_i \frac{f(X_i)}{\sqrt{n}} - \sum_{i=1}^n \varepsilon_i \frac{g(X_i)}{\sqrt{n}}\right| \ge u \mid X_1, \dots, X_n\right) \le 2e^{-u^2/(2\|f - g\|_n^2)}$$

$$\forall f, g \in \mathcal{F}, \forall u \geq 0$$

The value $\sigma_{n,2}^2 := \sup_{f \in \mathcal{F}} \mathbb{P}_n f^2 = \sup_{f \in \mathcal{F}} \|f\|_n^2$ is an upper bound for the squared radius of $\mathcal{F} \cup \{0\}$ with respect to this norm. We add the function $f \equiv 0$ to \mathcal{F} , so that the symmetrised process is zero at some parameter.

Theorem 4.3 (with $X_{t_0} = 0$) gives

$$\mathbb{E}_{\varepsilon} \left\| \mathbb{G}_{n}^{o} \right\|_{\mathcal{F}} \lesssim \int_{0}^{\sigma_{n,2}} \sqrt{\log N\left(\epsilon, \mathcal{F} \cup \{0\}, L_{2}\left(\mathbb{P}_{n}\right)\right)} d\epsilon$$

where \mathbb{E}_{ε} is the expectation with respect to the Rademacher variables.

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Proof of Theorem 4.7 (continued)

The right side can be bounded by

$$\int_{0}^{\sigma_{n,2}/\|F\|_{n}} \sqrt{\log N\left(\epsilon \|F\|_{n}, \mathcal{F} \cup \{0\}, L_{2}\left(\mathbb{P}_{n}\right)\right)} d\epsilon \|F\|_{n} \leq J\left(\theta_{n}, \mathcal{F}, F\right) \|F\|_{n}$$

Since $\theta_n \leq 1$, we have that $J(\theta_n, \mathcal{F}, F) \leq J(1, \mathcal{F}, F)$. Furthermore, by Jensen's inequality applied to the root function,

$$\mathbb{E}||F||_n \le \sqrt{\mathbb{E}\left[\frac{1}{n}\sum_{i=1}^n F^2(X_i)\right]} = ||F||_{P,2}$$

This gives the inequality on the right side of the theorem.

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Thank you!